

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/059,182	SUURONEN ET AL.	
Examiner	Art Unit	•
Yin-Chen Shaw	2135	

SEARCHED						
Class	Subclass	Date	Examiner			
						
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INTERFERENCE SEARCHED						
Class	Subclass	Date	Examiner			
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(INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Appeal Conf.: 1. Eddie Lee (SPE) 2. Taghi Arani (Primary Examiner)	2/15/2007	YCS		
Appeal Decision: 1. The Brief itself is defective. After Appellant fixed the brief, proceed to BPAI with Examiner answer	2/15/2007	YCS		